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捷多邦,专业PCB打样工厂SN54时0640送SN74HC640 OCTAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS SCLS303B – JANUARY 1996 – REVISED JUNE 2000

- Inverting Logic
- High-Current 3-State Outputs Can Drive up to 15 LSTTL Loads
- Package Options Include Plastic Small-Outline (DW), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

description

These octal bus transceivers are designed for asynchronous two-way communication between data buses. These devices transmit data from the A bus to the B bus or from the B bus to the A bus, depending upon the level at the direction-control (DIR) input. The output-enable (\overline{OE}) input can be used to disable the device so the buses are effectively isolated.

The SN54HC640 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74HC640 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE
(each transceiver)

INP	UTS	OPERATION	
OE	DIR	OPERATION	
L	L	B data to A bus	
L	Н	A data to B bus	
Н	Х	Isolation	100
Н	Х	Isolation	-0

SN54HC64	10 J O	R W PAC	KAGE
SN74HC640.	. DW, N,	OR PW F	PACKAGE
	(TOP VI	EW)	

DIR		U	20	
A1	2		19] OE
A2	3		18] B1
A3	4		17] B2
A4	5		16] B3
A5	6		15] B4
A6	[7		14] B5
A7	8		13] B6
A8	9		12] B7
GND	[10)	11] B8

SN54HC640...FK PACKAGE (TOP VIEW)

			A2	A1	DIR	V _{CC}	Ю			
A3 A4 A5 A6 A7	þ	l				> 20	19 19 1 1	18 [17 [16 [15]	B1 B2 B3 B4	
A7		8	Ť	10		12	13	4	B5	
			A8	GND	B8	B7	BG			

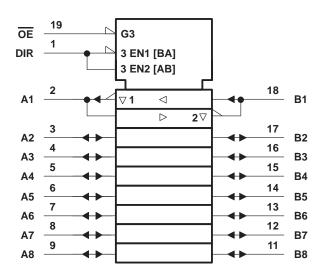


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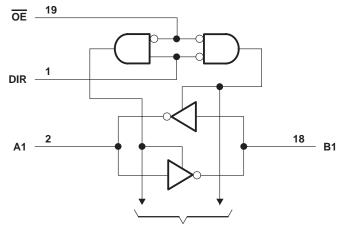
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logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



To Seven Other Transceivers



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}		io 7 V
Input clamp current, I_{IK} (V _I < 0 or V _I > V _{CC}) (see	e Note 1) ±2	20 mA
Output clamp current, I_{OK} (V _O < 0 or V _O > V _{CC}	c) (see Note 1) ±2	20 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±3	5 mA
Continuous current through V _{CC} or GND	±7	0 mA
Package thermal impedance, θ_{JA} (see Note 2):	DW package 58	°C/W
	N package 69	°C/W
	PW package	°C/W
Storage temperature range, T _{stg}		50°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 3)

			SN	154HC64	10	SN	174HC64	0	UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		2	5	6	2	5	6	V
		V _{CC} = 2 V	1.5			1.5			
VIH	High-level input voltage	V _{CC} = 4.5 V	3.15			3.15			V
		V _{CC} = 6 V	4.2			4.2			
		$V_{CC} = 2 V$	0		0.5	0		0.5	
VIL	VIL Low-level input voltage	V _{CC} = 4.5 V	0		1.35	0		1.35	V
		V _{CC} = 6 V	0		1.8	0		1.8	
VI	Input voltage		0		VCC	0		VCC	V
Vo	Output voltage		0		VCC	0		VCC	V
		$V_{CC} = 2 V$	0		1000	0		1000	
tt	Input transition (rise and fall) time	V _{CC} = 4.5 V	0		500	0		500	ns
		V _{CC} = 6 V	0		400	0		400	
Тд	Operating free-air temperature		-55		125	-40		85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	AMETER	TEST CO	NDITIONS	N	Т	A = 25°C	;	SN54H	C640	SN74HC640		UNIT
		TEST CO	NDITION3	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
				2 V	1.9	1.998		1.9		1.9		
		VI = VIH or VIL	I _{OH} = -20 μA	4.5 V	4.4	4.499		4.4		4.4		
Vон				6 V	5.9	5.999		5.9		5.9		V
			I _{OH} = –6 mA	4.5 V	3.98	4.3		3.7		3.84		
			I _{OH} = -7.8 mA	6 V	5.48	5.8		5.2		5.34		
			2 V		0.002	0.1		0.1		0.1		
			I _{OL} = 20 μA	4.5 V		0.001	0.1		0.1		0.1	
VOL		$V_I = V_{IH} \text{ or } V_{IL}$		6 V		0.001	0.1		0.1		0.1	V
			I _{OL} = 6 mA	4.5 V		0.17	0.26		0.4		0.33	
			I _{OL} = 7.8 mA	6 V		0.15	0.26		0.4		0.33	
Ц	DIR or OE	$V_I = V_{CC} \text{ or } 0$		6 V		±0.1	±100		±1000		±1000	nA
loz	A or B	VO = ACC or 0		6 V		±0.01	±0.5		±10		±5	μΑ
ICC		$V_{I} = V_{CC} \text{ or } 0,$	I _O = 0	6 V			8		160		80	μΑ
Ci	DIR or OE			2 V to 6 V		3	10		10		10	pF

switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	Vaa	Τ ₄	λ = 25°C	;	SN54H	C640	SN74H	IC640	UNIT	
FARAMETER	(INPUT)	(OUTPUT)	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
			2 V		29	105		160		130		
^t pd	A or B	B or A	4.5 V		10	21		32		26	ns	
			6 V		8	18		27		22		
			2 V		109	230		340		290		
t _{en}	OE	A or B	4.5 V		27	46		68		58	- 1	
			6 V		20	39		58		49		
			2 V		40	150		225		190		
^t dis	OE	A or B	4.5 V		18	30		45		38	ns	
			6 V		16	26		38		32		
			2 V		20	60		90		75		
tt		A or B	A or B	4.5 V		8	12		18		15	ns
			6 V		6	10		15		13		

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switching characteristics over recommended operating free-air temperature range, $C_L = 150 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	Vaa	Τ _Α	ן = 25°C	;	SN54H	C640	SN74H	C640	UNIT
FARAMETER	(INPUT)		Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V		44	190		290		235	
^t pd	A or B	B or A	4.5 V		14	38		58		47	ns
			6 V		11	33		49		41	
			2 V		124	315		470		395	
ten	ŌĒ	A or B	4.5 V		31	63		94		79	ns
			6 V		23	54		80		68	
			2 V		45	210		315		265	
tt		A or B	4.5 V		17	42		63		53	ns
			6 V		13	36		53		45	

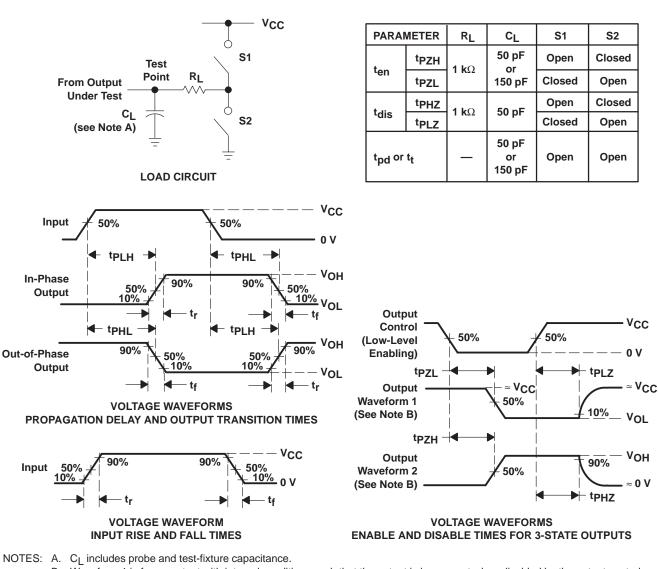
operating characteristics, $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load	40	pF



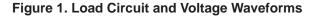
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PARAMETER MEASUREMENT INFORMATION

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_r = 6 ns, t_f = 6 ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tp71 and tp7H are the same as ten.
- G. tPLH and tPHL are the same as tpd.





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